

Notice of References Cited	Application/Control No. 10/708,584	Applicant(s)/Patent Under Reexamination SMITH, DEBRA	
	Examiner KEVIN POE	Art Unit 3693	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,310,615	12-2007	Lewis, Charles J.	705/35
*	B	US-2005/0096927	05-2005	Mehta et al.	705/001
*	C	US-6,856,970	02-2005	Campbell et al.	705/35
*	D	US-2003/0097327	05-2003	Anaya et al.	705/37
*	E	US-2006/0082055	04-2006	Chen, Samuel	273/126.00R
*	E	US-2002/0004773	01-2002	Xu et al.	705/36
*	G	US-5,754,655	05-1998	Hughes et al.	705/70
*	H	US-2002/0046484	01-2002	Lundgren, Sharon	47/29.6
*	I	US-2002/0042795	04-2002	Smith, David	707/201
*	J	US-2003/0120619	06-2003	Osborn, Mark David	706/19
*	K	US-2006/0041493	02-2006	Schulze et al.	705/035
*	L	US-2003/0120619	06-2003	Osborn, Mark David	706/19
*	M	US-2006/0041493	02-2006	Schulze et al.	705/035

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.